

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/772,489	SIEMENS ET AL.	
Examiner	Art Unit	
Daniel I. Walsh	2876	

SEARCHED					
Class	Subclass	Date	Examiner		
705	39-45	2/3/2006	DW		
235	375,379	2/3/2006	DW		
235	380, 382	2/3/2006	DW		
235	385	2/3/2006	DW		
902	8,9,14,15	2/3/2006	DW		
232	4r	2/3/2006	DW		
109	24.1,56	2/3/2006	DW		

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
same	as above	2/3/2006	DW			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Search attached	2/3/2006	DW		
consulted J. Hayes class 705	2/3/2006	DW		
consulted L. Gall class 109	2/3/2006	DW		
class 705, 235, 194, 271, 109, and 232 keyword search (see attached)	2/3/2006	DW		